

Prüfbericht-Nr.: <i>Test Report No.:</i>	50041195 002	Auftrags-Nr.: <i>Order No.:</i>	114066608	Seite 1 von 17 <i>Page 1 of 17</i>
Kunden-Referenz-Nr.: <i>Client Reference No.:</i>	N/A	Auftragsdatum: <i>Order date:</i>	08-Jun-2017	
Auftraggeber: <i>Client:</i>	Microchip Technology Inc., 2355 West Chandler Blvd. Chandler, Arizona 85224-6199, United States.			
Prüfgegenstand: <i>Test item:</i>	Bluetooth module			
Bezeichnung / Typ-Nr.: <i>Identification / Type No.:</i>	BM64SPKS1NC1			
Auftrags-Inhalt: <i>Order content:</i>	FCC Part 15C/IC RSS-247 (Class II Permissive Change) Test report(FHSS) spurious radiated emissions only			
Prüfgrundlage: <i>Test specification:</i>	FCC 47CFR Part 15: Subpart C Section 15.247 RSS-247 (02-2017)			
Wareneingangsdatum: <i>Date of receipt:</i>	25-Jul-2017			
Prüfmuster-Nr.: <i>Test sample No.:</i>	A000577774-001 A000577774-002			
Prüfzeitraum: <i>Testing period:</i>	02-Aug-2017 - 03-Aug-2017			
Ort der Prüfung: <i>Place of testing:</i>	EMC Laboratory Taipei			
Prüflaboratorium: <i>Testing laboratory:</i>	TUV Rheinland Taiwan Ltd.			
Prüfergebnis*: <i>Test result*:</i>	Pass			
Report Date / tested by:		kontrolliert von / reviewed by:		
2017-09-04 Ryan W. T. Chen / Project Manager		2017-09-04 Arvin Ho/Vice General Manager		
Datum <i>Date</i>	Name / Stellung <i>Name / Position</i>	Unterschrift <i>Signature</i>	Datum <i>Date</i>	Name / Stellung <i>Name / Position</i>
Sonstiges / Other:				
Change RF IC to ROM version and package different.				
Zustand des Prüfgegenstandes bei Anlieferung: <i>Condition of the test item at delivery:</i>		Prüfmuster vollständig und unbeschädigt <i>Test item complete and undamaged</i>		
* Legende: 1 = sehr gut 2 = gut 3 = befriedigend 4 = ausreichend 5 = mangelhaft P(ass) = entspricht o.g. Prüfgrundlage(n) F(ail) = entspricht nicht o.g. Prüfgrundlage(n) N/A = nicht anwendbar N/T = nicht getestet Legend: 1 = very good 2 = good 3 = satisfactory 4 = sufficient 5 = poor P(ass) = passed a.m. test specification(s) F(ail) = failed a.m. test specification(s) N/A = not applicable N/T = not tested				
Dieser Prüfbericht bezieht sich nur auf das o.g. Prüfmuster und darf ohne Genehmigung der Prüfstelle nicht auszugsweise vervielfältigt werden. Dieser Bericht berechtigt nicht zur Verwendung eines Prüfzeichens. <i>This test report only relates to the a. m. test sample. Without permission of the test center this test report is not permitted to be duplicated in extracts. This test report does not entitle to carry any test mark.</i>				

TEST SUMMARY

5.1.1 SPURIOUS EMISSION

RESULT: Passed

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1. General Remarks

1.1 Complementary Materials

The following attachments are integral parts of this test report:

Appendix P: Photo Documentation internal view
(File Name: 50041195 002 APPENDIX P)

Appendix D: Test Result of Radiated Emissions
(File Name: 50041195 002 APPENDIX D)

Test Specifications

The following standards were applied

Table 1: Applied Standard and Test Levels

Radio
FCC CFR47 Part 15: Subpart C Section 15.247 RSS-247 Issue 2 May 2017 RSS-Gen, Issue 4, November 2014 ANSI C63.10:2013

2. Test Sites

2.1 Test Facility

TUV Rheinland Taiwan Ltd.
Taipei Office

11F. No.758, Sec. 4, Bade Rd., Songshan Dist.
Taipei City 105
Taiwan (R.O.C.)

FCC RegistrationNo.: 340738
IC Canada Registration No.: 9465A-1
TAF Accredited NCC Test Lab. No.:0759
TAF ISO17025 Certification effective periods: 2016-Jul-1st to 2019-Jun-30th



Testing Laboratory
0759

2.2 List of Test and Measurement Instruments

Table 2: List of Test and Measurement Equipment

Kind of Equipment	Manu-facturer	Type	S/N	Last Calibration	Next Calibration
Test Software	Farad	EZ_EMC	Ver. TUV3A1	N/A	N/A
EMI Test Receiver	R&S	ESR7	101062	2016/09/12	2017/09/12
Spectrum Analyzer	R&S	FSV 40	100921	2017/05/02	2018/05/01
Spectrum Analyzer	Agilent	N9010A	MY53470241	2017/05/23	2018/05/22
Preamplifier (30MHz -1GHz)	HP	8447D	2944A06641	2016/12/28	2017/12/28
Preamplifier (18 GHz -40 GHz)	COM-POWER	PAM-840	461257	2016/12/01	2017/12/01
Pre-Amplifier (1GHz~18GHz)	EM Electronics	EM01G18G	060558	2016/11/17	2017/11/17
Bilog Antenna	TESEQ	CBL6111D	29802	2017/07/12	2018/07/12
Horn Antenna	ETS-Lindgren	3117	138160	2017/05/25	2018/05/25
Horn Antenna (18GHz~40GHz)	COM-POWER	AH-840	101031	2016/11/22	2017/11/22
Loop Antenna	Schwarzbeck	FMZB 1513	1513-076	2017/06/14	2018/06/14
EMI Test Receiver	R&S	ESCi7	100797	2016/12/30	2017/12/30
Spectrum Analyzer	R&S	FSL3	101943	2015/09/07	2017/09/07
Temp. & Humid. Chamber	WISEWIND	1509	509Q24R	2017/05/24	2018/05/24
LISN (1 phase)	R&S	ENV216	101243	2017/06/18	2018/06/18
LISN	R&S	ENV216	101262	2017/06/22	2018/06/21

2.3 Traceability

All measurement equipment calibrations are traceable to NML(Taiwan)/NIST(USA) or where calibration is performed outside Taiwan, to equivalent nationally recognized standards organizations.

2.4 Calibration

requiring calibration is calibrated periodically in a suitably accredited Calibration Lab. Additionally all equipment is verified for proper performance on a regular basis using in house standards or comparisons.

2.5 Measurement Uncertainty

The estimated combined standard uncertainty for radiated emissions and conducted emissions measurements:.

Table 3: Emission Measurement Uncertainty

Parameter	Uncertainty
RF power, conducted	± 1.5 dB
Adjacent channel power	± 3 dB
Radiated emission of transmitter, valid up to 26 GHz	± 6 dB
Radiated emission of receiver, valid up to 26 GHz	± 6 dB
Temperature	± 2 °C
Humidity	± 10 %

3. General Product Information

3.1 Product Function and Intended Use

"The EUT is a fully qualified Bluetooth version 4.2 (BDR/EDR/BLE) module for designers to add Bluetooth wireless audio and voice applications to their products."

For details refer to the User Guide, Data Sheet and Circuit Diagram.

3.2 System Details and Ratings

Table 4: Basic Information of EUT

Item	EUT information
Kind of Equipment/Test Item	Bluetooth module
Type Identification	BM64SPKS1NC1
Brand Name	Microchip
FCC ID	A8TBM64S1
Canada ID	12246A-BM64S1
Canada HVIN	BM64SPKS1MC1

Table 5: Technical Specification of EUT

Technical Specification	Value
Operating Frequency	2402 MHz ~ 2480 MHz
Channel Spacing	1 MHz
Channel number	79
Operation Voltage	3.2V~4.2V, tested in 3.3V
Modulation	GFSK, $\pi/4$ DQPSK, 8 DPSK
Antenna gain	1.927 dBi max@2.400 GHz

Table 6: Frequency hopping information

Technical Specification	Description
Hopping Range	Hereby we declare that the maximum frequency of this device is: 2402-2480MHz. This is according the Bluetooth Core Specification V2.1+EDR for devices which will be operated in the USA. This was checked during the Bluetooth Qualification tests (Test Case: TRM/CA/04).
Hopping Sequence	Example of a 79 hopping sequence in data mode: 33,04,21,44,23,42,53,46,55,48,40,59,72,29,76,31,08,73,07,75,09,45,60,39,58,13,47,11,77,52,35,50,65,54,67,56,69,62,71,64, 7,25,27,66,57,70,74,61,78,63,10,41,05,43,15,44,64,68,02,70,06,01,51,03,55,05,03,66,53,49,36,47,
Receiver input bandwidth	The input bandwidth of the receiver is 1MHz. In every connection one Bluetooth device is the master and the other one is the slave. The master determines the hopping sequence. The slave follows this sequence. Both devices shift between RX and TX time slot according to the clock of the master. Additionally the type of connection is set up at the beginning of the connection. The master adapts its hopping frequency and its TX/RX timing according to the packet type of the connection. Also the slave of the connection will use these settings. Repeating of a packer has no influence on the hopping sequence. The hopping sequence generated by the master of the connection will be followed in any case. That means a repeated packet will not be send on the same frequency, it is send on the next frequency of the hopping sequence.

3.3 Independent Operation Modes

The basic operation modes are:

- A. Transmitting
 - 1. Low channel
 - 2. Middle channel
 - 3. High channel

3.4 Noise Generating and Noise Suppressing Parts

Refer to the Circuit Diagram.

3.5 Submitted Documents

- Circuit Diagram
- Instruction Manual
- Rating Label
- Technical Description

4. Test Set-up and Operation Modes

4.1 Principle of Configuration Selection

The equipment under test (EUT) was configured to measure its maximum power level. The test modes were adapted accordingly in reference to the instructions for use.

4.2 Test Operation and Test Software

Setup for testing:

Test samples are provided with a USB interface which makes it possible to control them through test software installed on a notebook computer.

The samples were used as follows:

Conducted: **A000577774-002**

Radiation: **A000577774-001**

Full test was applied on all test modes, but only worst case was shown.

4.3 Special Accessories and Auxiliary Equipment

The product has been tested together with the following additional accessories:

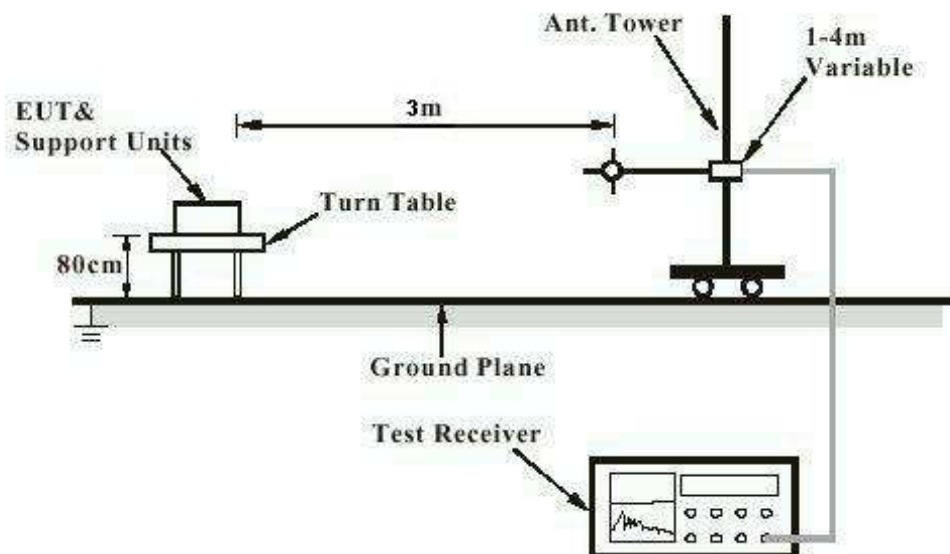
Description	Manufacturer	Model No.	Serial No.
Notebook(EMC-06)	Lenovo	TP00048A	PB-0F8B2

4.4 Countermeasures to achieve EMC Compliance

The test sample which has been tested containing the noise suppression parts as in the Photo Appendix and the Test Setup Photos. No additional measures were employed to achieve compliance.

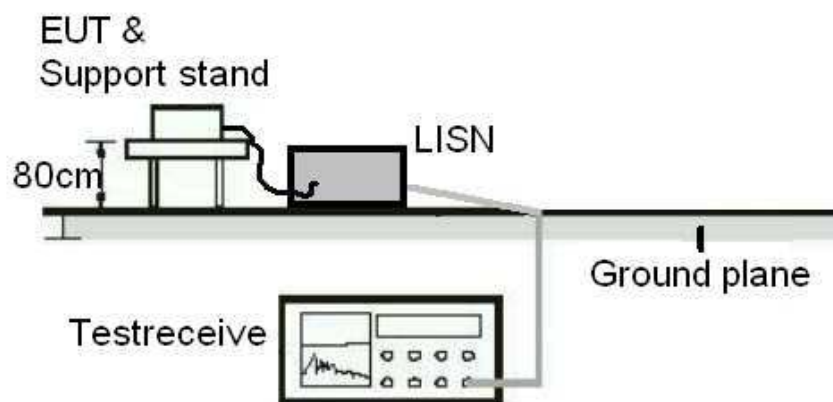
4.5 Test Setup Diagram

Diagram of Measurement Configuration for Radiation Test



Note: Measurements above 1 GHz are done with a table height of 1.5m

Diagram of Measurement Equipment Configuration for Mains Conduction Measurement



5. Test Results

5.1.1 Spurious Emission

RESULT:**Passed**

Test standard	:	FCC part 15.247(d), FCC 15.205, FCC 15.209, RSS-210 2.2, RSS-247 5.5 and RSS-Gen 8.9 LP0002(2016): 3.10.1.5
Basic standard	:	ANSI C63.10
Limits	:	Radiated emissions which fall in the restricted bands, as defined in FCC 15.205(a) and RSS-Gen i4, 8.9 (Table 6), must comply with the radiated emission limits specified in FCC 15.209(a) and RSS-Gen i4, 8.9 (Table 4 and 5). Radiated emissions which fall in the restricted bands, as defined in LP0002(2016): 2.7 , must comply with the radiated emission limits specified in LP0002(2016): 2.8 Emission radiated outside the specified frequency bands must comply with the radiated emission limits specified in FCC 15.209(a) and FCC 15.249(a), RSS-Gen i4, 8.9 (Table 4 and 5) and RSS-210 A2.9(a). Emission radiated outside the specified frequency bands must comply with the radiated emission limits specified in LP0002(2016): 2.8
Kind of test site	:	3m Semi-Anechoic Chamber

Test setup

Test Channel	:	Low/ Middle/ High
Operation Mode	:	A, B

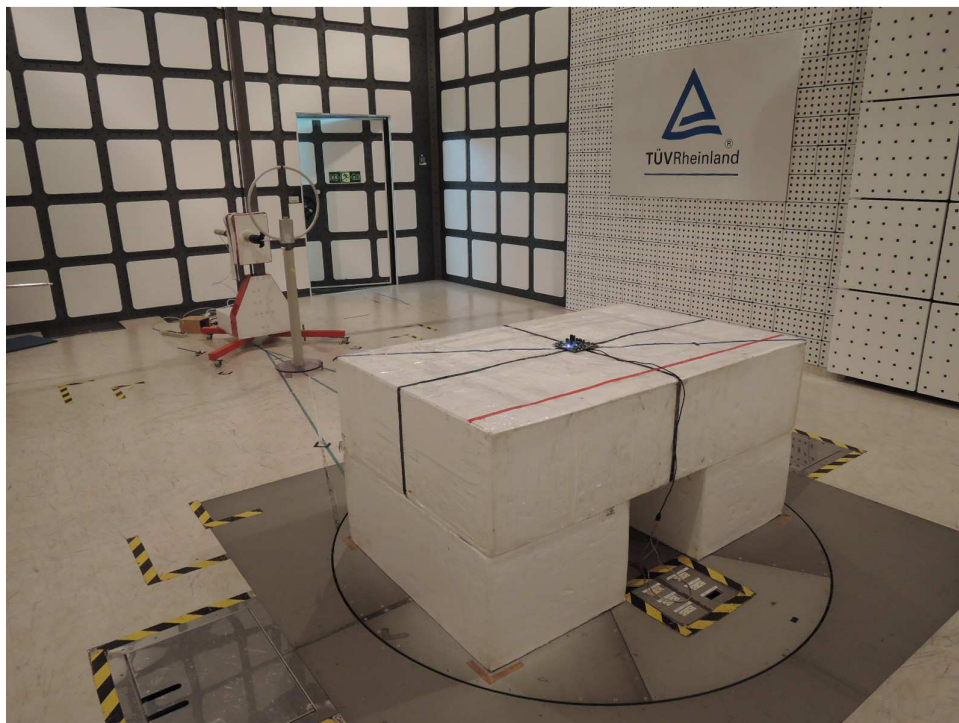
Remark: Testing was carried out within frequency range 30MHz to the tenth harmonic. For details refer to Appendix D. The Radiated Emissions testing was performed in the X, Y and Z axis orientation. The worst-case Axis orientation is recorded in this test report. Due to the small size of the product and that there are no inductive components of significant size, 9kHz to 30MHz frequency range is not tested based on technical judgment.

6. Photographs of the Test Set-Up

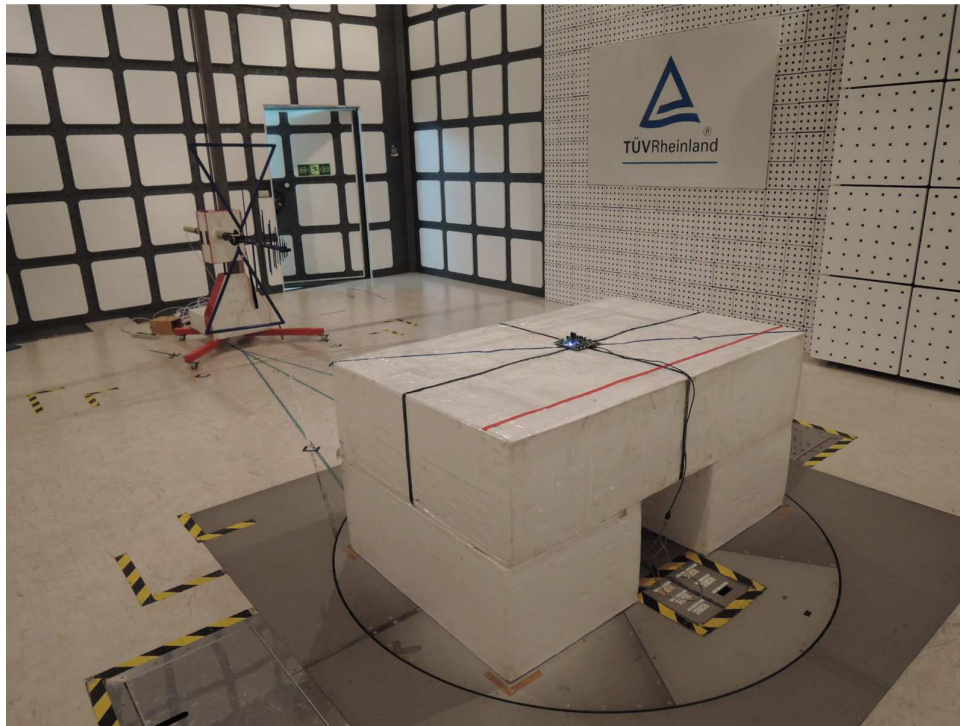
Photograph 1: Set-up for Spurious Emissions (Front View)



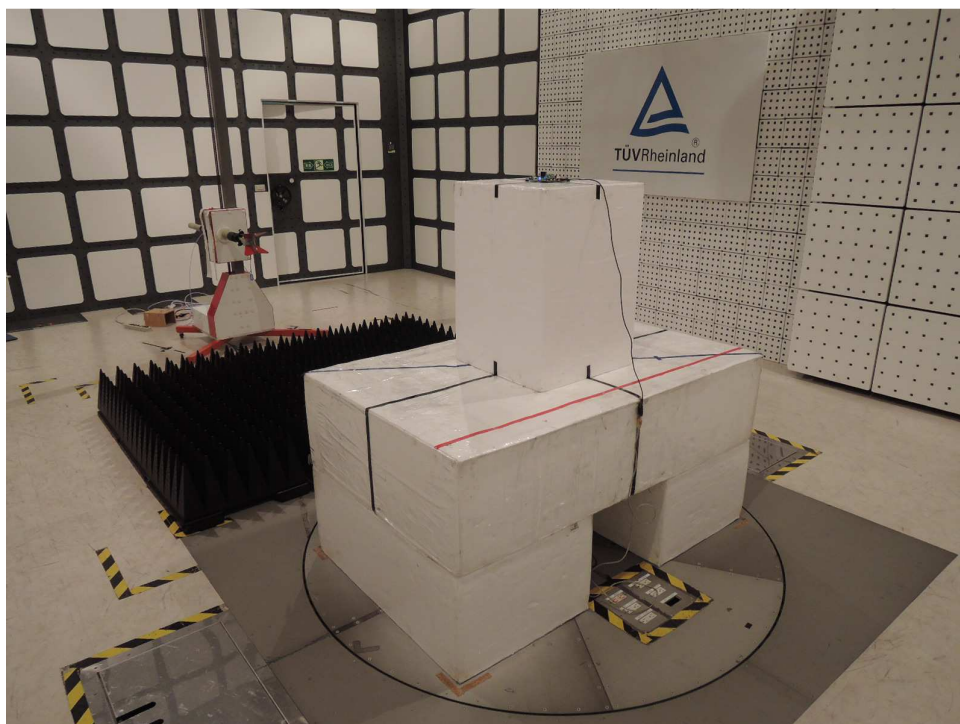
Photograph 2: Set-up for Spurious Emissions (Back View 1)



Photograph 3: Set-up for Spurious Emissions (Back View 2)



Photograph 4: Set-up for Spurious Emissions (Back View 3)



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